

Notice of References Cited	Application/Control No. 10/676,017	Applicant(s)/Patent Under Reexamination CHOU ET AL.	
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	B	US-6,096,015 A	08-2000	Yeo et al.	604/371
	C	US-6,162,327 A	12-2000	Batra et al.	162/109
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	N	EP 0810078	03-1997	EP	Schmidt et al	
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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